

<b>Notice of References Cited</b>	Application/Control No. 10/084,827	Applicant(s)/Patent Under Reexamination KNOWLES ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0102379	06-2003	Tsikos et al.	235/462.45
*	B	US-2003/0098353	05-2003	Tsikos et al.	235/472.01
*	C	US-2003/0098349	05-2003	Tsikos et al.	235/462.01
*	D	US-2003/0094495	05-2003	Knowles et al.	235/462.14
*	E	US-2003/0089778	05-2003	Tsikos et al.	235/454
*	F	US-2003/0085281	05-2003	Knowles et al.	235/454
*	G	US-2003/0085280	05-2003	Tsikos et al.	235/454
*	H	US-2003/0080192	05-2003	Tsikos et al.	235/462.14
*	I	US-2003/0071128	04-2003	Tsikos et al.	235/470
*	J	US-2003/0071124	04-2003	Tsikos et al.	235/454
*	K	US-2003/0071123	04-2003	Tsikos et al.	235/454
*	L	US-2003/0071122	04-2003	Tsikos et al.	235/454
*	M	US-2003/0071119	04-2003	Tsikos et al.	235/434

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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